

<b>Notice of References Cited</b>	Application/Control No. 09/682,303	Applicant(s)/Patent Under Reexamination CHEN ET AL	
	Examiner An T. Luu	Art Unit 2816	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,489,823	12-2002	Iwamoto, Hisashi	327/158
	B	US-6,483,359	11-2002	Lee, Seong-Hoon	327/158
	C	US-6,456,129	09-2002	Tsukude, Masaki	327/156
	D	US-6,388,480	05-2002	Stubbs et al.	327/156
	E	US-6,100,736	08-2000	Wu et al.	327/159
	F	US-5,910,740	06-1999	Underwood, George D.	327/149
	G	US-5,771,264	06-1998	Lane, Chris	375/376
	H	US-5,687,202	11-1997	Eitrheim, John K.	375/376
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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